



FDMS8670

N-Channel Power Trench® MOSFET

30V, 42A, 2.6mΩ

Features

- Max $r_{DS(on)}$ = 2.6mΩ at $V_{GS} = 10V$, $I_D = 24A$
- Max $r_{DS(on)}$ = 3.8mΩ at $V_{GS} = 4.5V$, $I_D = 18A$
- 100% UIL Tested
- RoHS Compliant

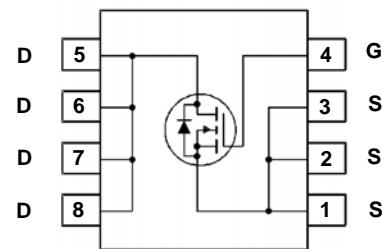
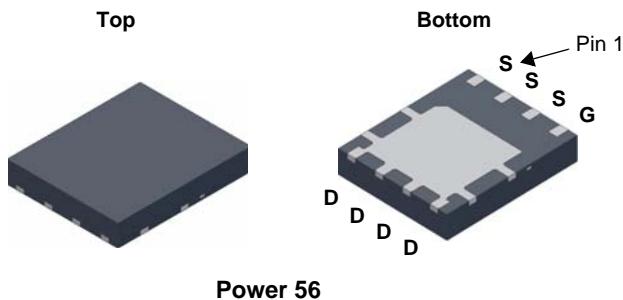


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's latest proprietary Power Trench® process that has been especially tailored to minimize on-resistance. This part exhibits industry leading switching FOM ($R_{DS(on)} \cdot Q_{gd}$) to enhance DC-DC synchronous rectifier efficiency.

Application

- DC - DC Conversion



MOSFET Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	30	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current -Continuous (Package limited) $T_C = 25^\circ C$	42	A
	-Continuous (Silicon limited) $T_C = 25^\circ C$	135	
	-Continuous $T_A = 25^\circ C$ (Note 1a)	24	
	-Pulsed	150	
E_{AS}	Single Pulse Avalanche Energy (Note 3)	288	mJ
P_D	Power Dissipation $T_C = 25^\circ C$	78	W
	Power Dissipation $T_A = 25^\circ C$ (Note 1a)	2.5	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8670	FDMS8670	Power 56	13"	12 mm	3000 units

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	30			V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		19.5		$\text{mV/}^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}, V_{DS} = 24\text{V}$,			1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			± 100	nA

On Characteristics

$V_{GS(\text{th})}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	1.0	1.7	3.0	V
$\frac{\Delta V_{GS(\text{th})}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		-5.9		$\text{mV/}^\circ\text{C}$
$r_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 24\text{A}$		2.1	2.6	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 18\text{A}$		3.0	3.8	
		$V_{GS} = 10\text{V}, I_D = 24\text{A}, T_J = 125^\circ\text{C}$		3.0	3.8	
g_{FS}	Forward Transconductance	$V_{DD} = 5\text{V}, I_D = 24\text{A}$		117		s

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 15\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		2965	3940	pF
C_{oss}	Output Capacitance			1395	1855	pF
C_{rss}	Reverse Transfer Capacitance			180	265	pF
R_g	Gate Resistance	$f = 1\text{MHz}$		1.3		Ω

Switching Characteristics

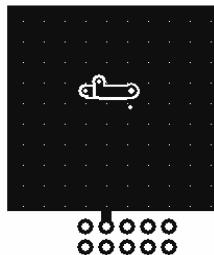
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{DD} = 15\text{V}, I_D = 24\text{A}, V_{GS} = 10\text{V}, R_{\text{GEN}} = 6\Omega$		14	24	ns
t_r	Rise Time			5	10	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time			33	53	ns
t_f	Fall Time			4	10	ns
Q_g	Total Gate Charge	$V_{GS} = 0\text{V} \text{ to } 10\text{V}$		45	63	nC
	Total Gate Charge	$V_{GS} = 0\text{V} \text{ to } 5\text{V}$	$V_{DD} = 15\text{V}, I_D = 24\text{A}$	23	33	nC
Q_{gs}	Gate to Source Charge			8.3		nC
Q_{gd}	Gate to Drain "Miller" Charge			5.7		nC

Drain-Source Diode Characteristics

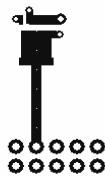
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 24\text{A}$ (Note 2)		0.8	1.3	V
		$V_{GS} = 0\text{V}, I_S = 2.1\text{A}$ (Note 2)		0.7	1.2	
t_{rr}	Reverse Recovery Time	$I_F = 24\text{A}, di/dt = 100\text{A}/\mu\text{s}$		44	71	ns
				27	43	nC

NOTES:

1. R_{0JA} is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a 1.5×1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 50°C/W when mounted on a 1in^2 pad of 2 oz copper.



b. 125°C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width $< 300\mu\text{s}$, Duty cycle $< 2.0\%$.

3. Starting $T_J = 25^\circ\text{C}$, $L = 1\text{mH}$, $I_{AS} = 24\text{A}$, $V_{DD} = 27\text{V}$, $V_{GS} = 10\text{V}$.

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

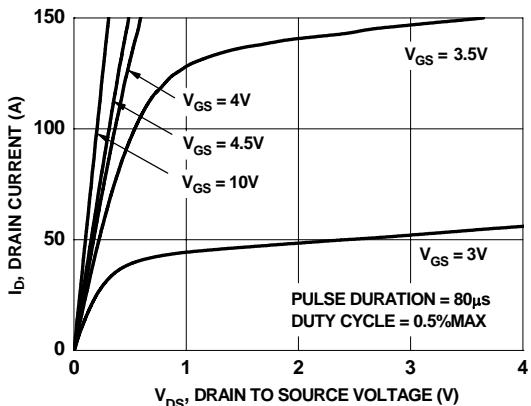


Figure 1. On-Region Characteristics

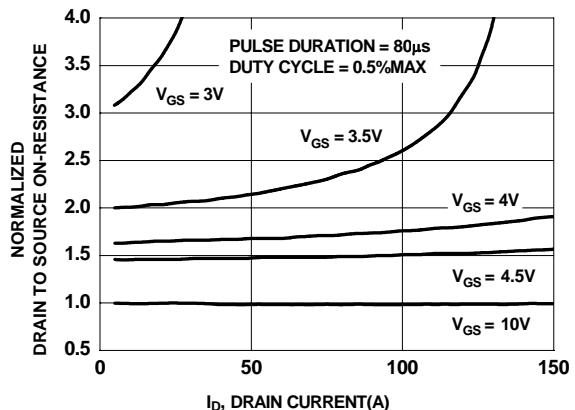


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

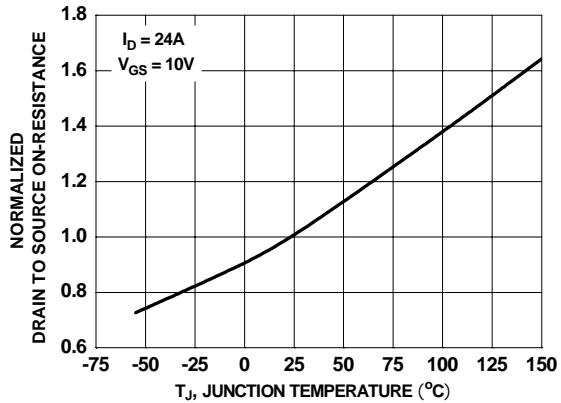


Figure 3. Normalized On-Resistance vs Junction Temperature

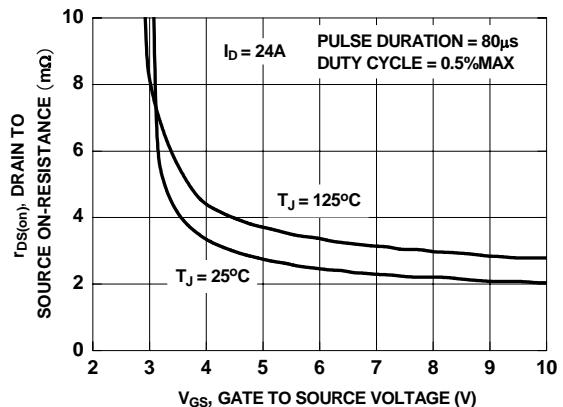


Figure 4. On-Resistance vs Gate to Source Voltage

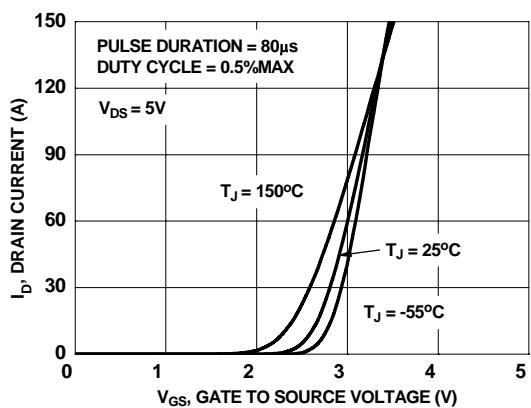


Figure 5. Transfer Characteristics

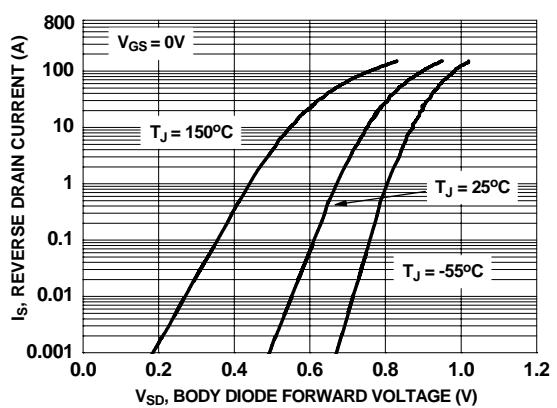


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

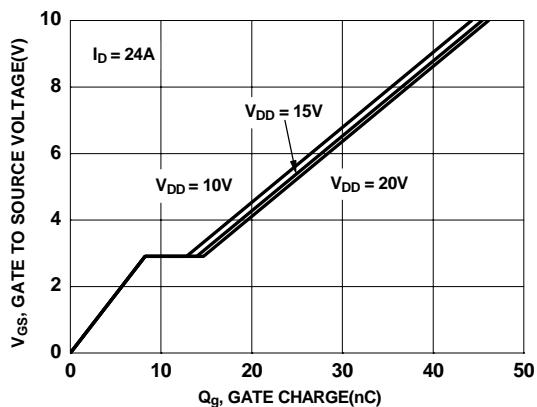


Figure 7. Gate Charge Characteristics

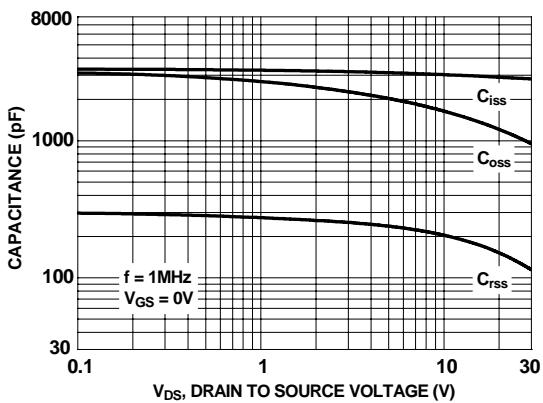


Figure 8. Capacitance vs Drain to Source Voltage

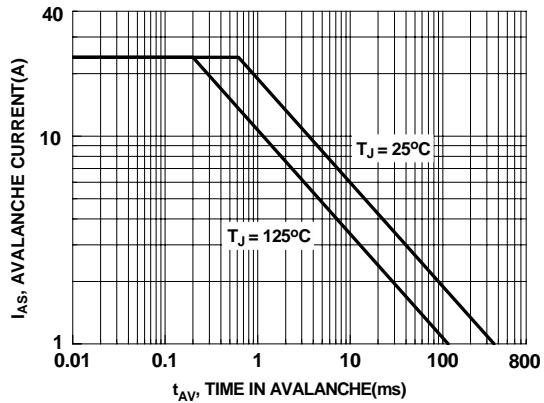


Figure 9. Unclamped Inductive Switching Capability

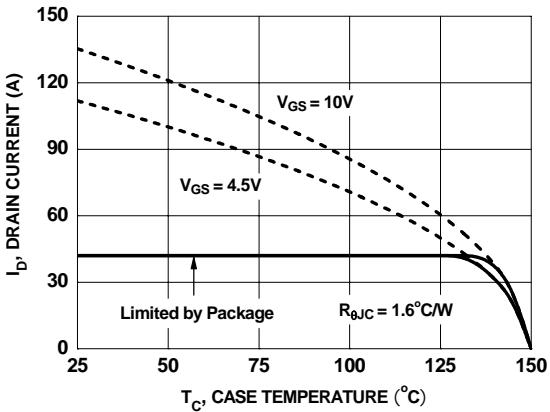


Figure 10. Maximum Continuous Drain Current vs Case Temperature

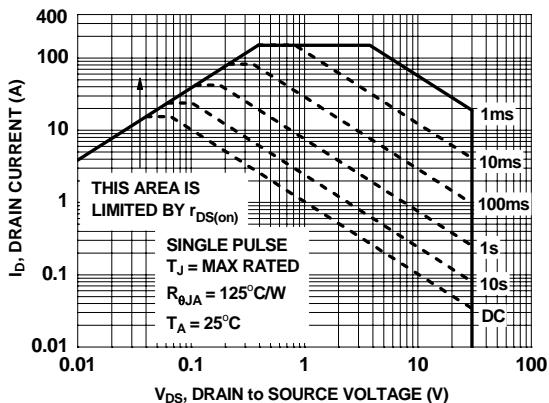


Figure 11. Forward Bias Safe Operating Area

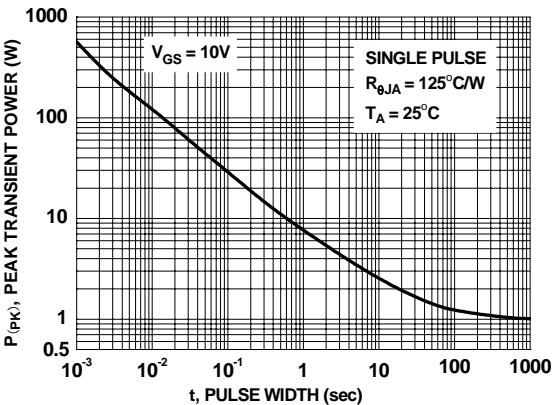


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

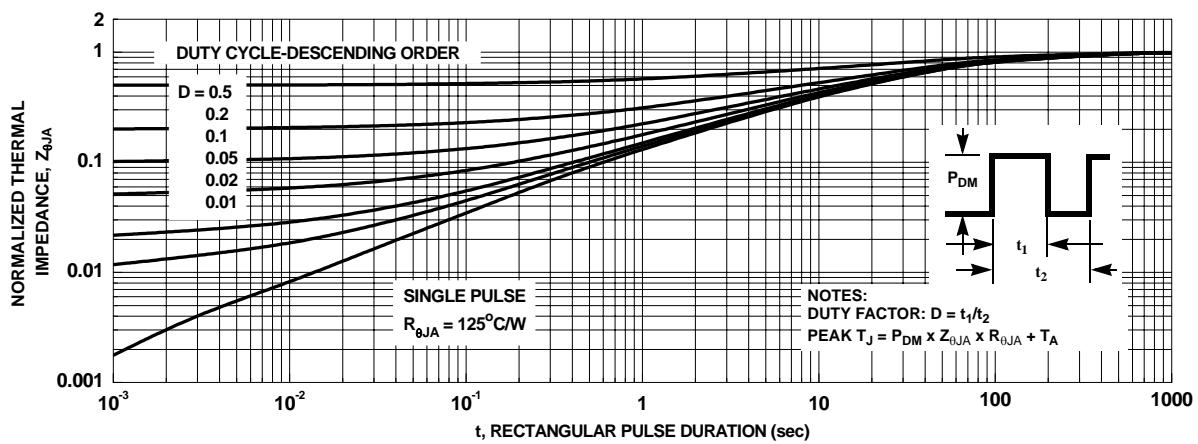
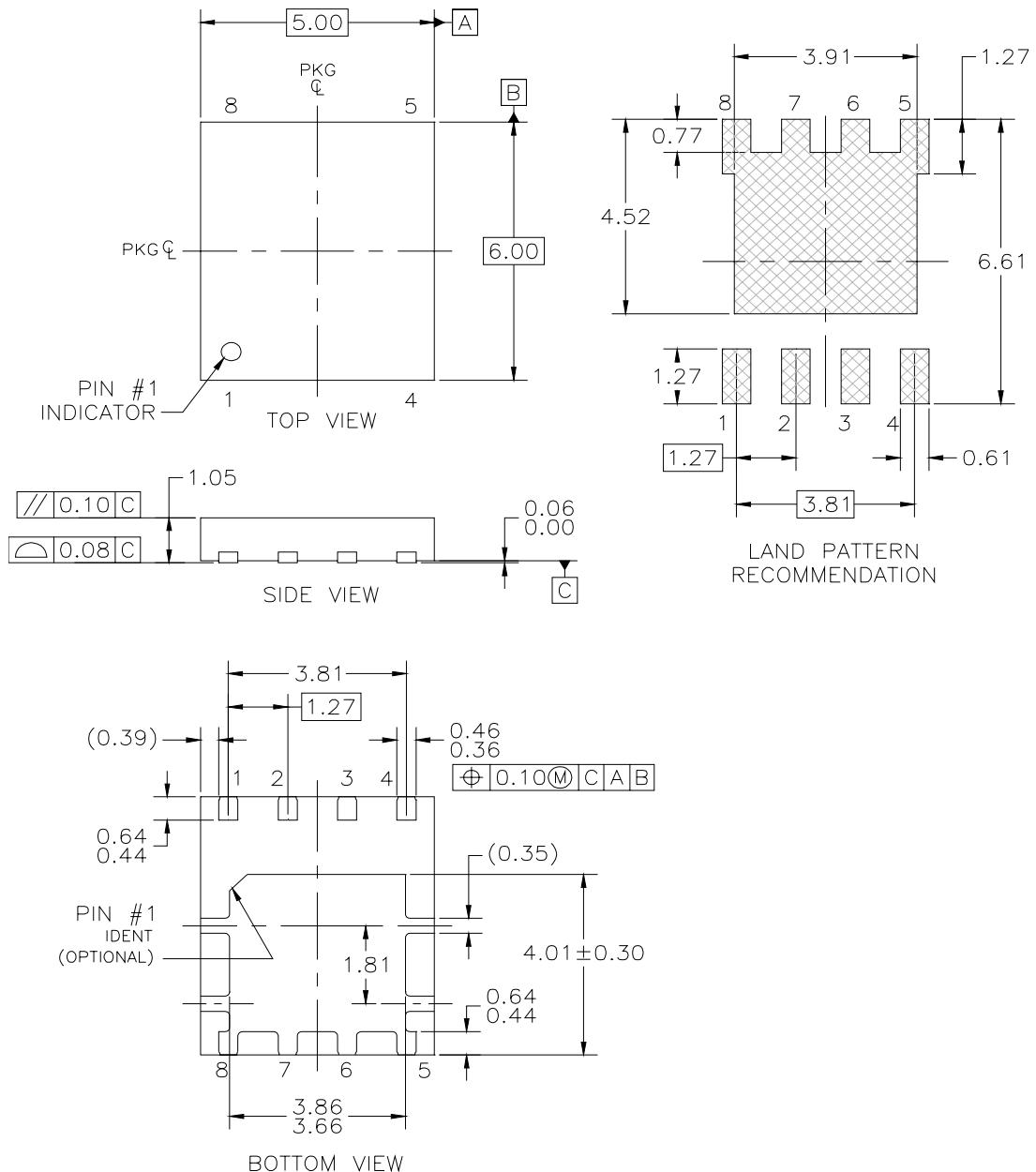


Figure 13. Transient Thermal Response Curve

Dimensional Outline and Pad Layout



NOTES: UNLESS OTHERWISE SPECIFIED
 A) ALL DIMENSIONS ARE IN MILLIMETERS.
 B) NO JEDEC REFERENCE AS OF FEBRUARY 2006
 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994

PQFN08AREVA



TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

ACE [®]	FPST [™]	PDP-SPM [™]	The Power Franchise [®]
Build it Now [™]	F-PFS [™]	Power-SPM [™]	the power franchise
CorePLUS [™]	FRFET [®]	PowerTrench [®]	TinyBoost [™]
CorePOWER [™]	Global Power Resource SM	Programmable Active Droop [™]	TinyBuck [™]
CROSSVOLT [™]	Green FPS [™]	QFET [®]	TinyLogic [®]
CTL [™]	Green FPS [™] e-Series [™]	QS [™]	TINYOPTO [™]
Current Transfer Logic [™]	GTO [™]	Quiet Series [™]	TinyPower [™]
EcoSPARK [®]	IntelliMAX [™]	RapidConfigure [™]	TinyPWM [™]
EfficientMax [™]	ISOPLANARTM	Saving our world 1mW at a time [™]	TinyWire [™]
EZSWITCH [™] *	MegaBuck [™]	SmartMax [™]	μSerDes [™]
	MICROCOUPLER [™]	SMART START [™]	
	MicroFET [™]	SPM [®]	UHC [®]
Fairchild [®]	MicroPak [™]	STEALTH [™]	Ultra FRFET [™]
Fairchild Semiconductor [®]	MillerDrive [™]	SuperFET [™]	UniFET [™]
FACT Quiet Series [™]	MotionMax [™]	SuperSOT [™] -3	VCX [™]
FACT [®]	Motion-SPM [™]	SuperSOT [™] -6	VisualMax [™]
FAST [®]	OPTOLOGIC [®]	SuperSOT [™] -8	
FastCore [™]	OPTOPLANAR [®]	SuperMOS [™]	
FlashWriter [®] *			

* EZSWITCH[™] and FlashWriter[®] are trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	This datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. I34